



Surface Sensitive X-ray Scattering



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Introduction

- Concepts of surfaces
- Scattering (Born approximation)

Crystal Truncation Rods

- The basic idea
- How to calculate
- Examples

Reflectivity

- In Born approximation
- Exact formalism (Fresnel)
- Examples

Grazing Incidence Diffraction

- The basic idea
- Penetration depth
- Example

Grazing Incidence Diffraction (GID) The basic idea

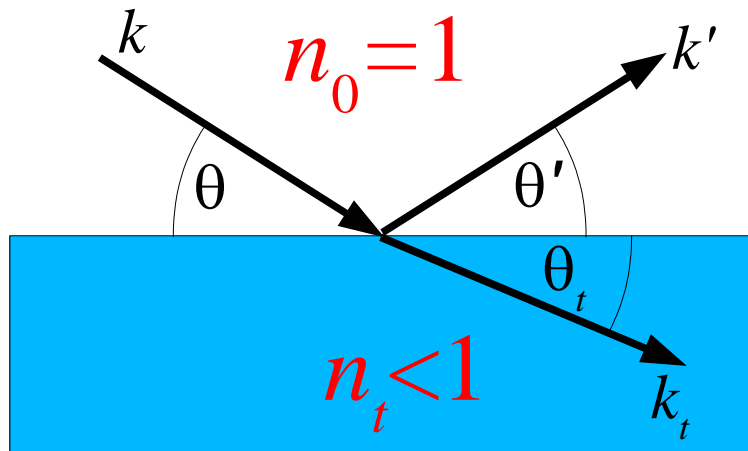
Mean value of the refractive index:

⇒ total external reflection

⇒ critical angle α_c

$$|n_t| = |1 - \delta + i\beta| < 1$$

$$\alpha_c \approx \sqrt{2\delta}$$



$$\theta > \alpha_c$$

- some x-rays penetrate the sample
- some x-rays are reflected (Fresnel)

transmitted amplitude

$$t_f = \frac{2k_z}{k_z + k_{t,z}}$$

reflected amplitude

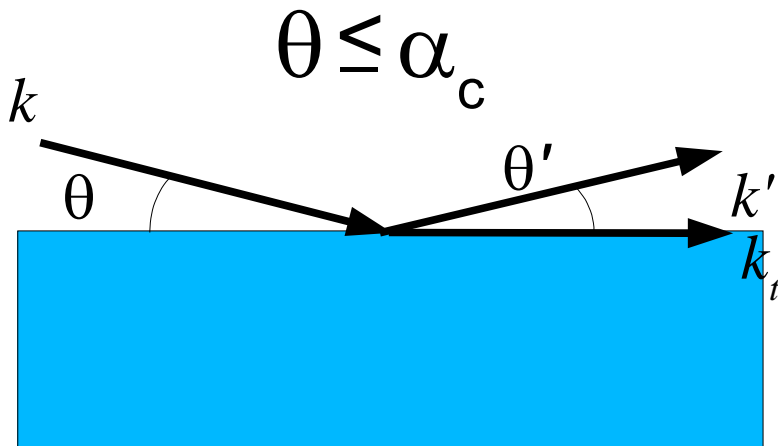
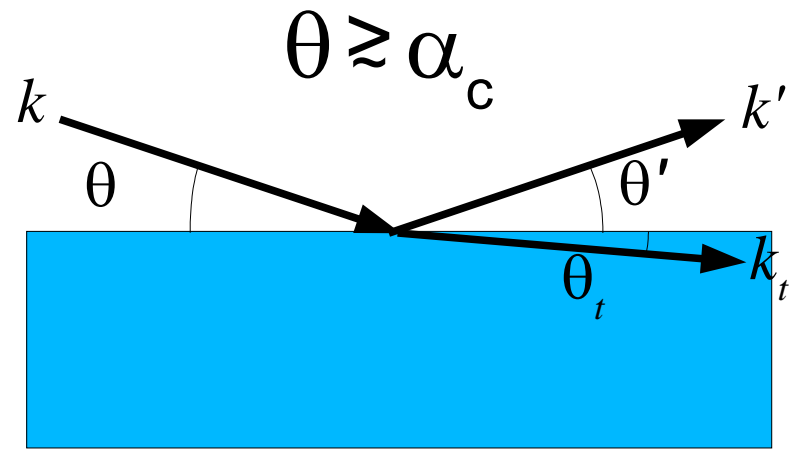
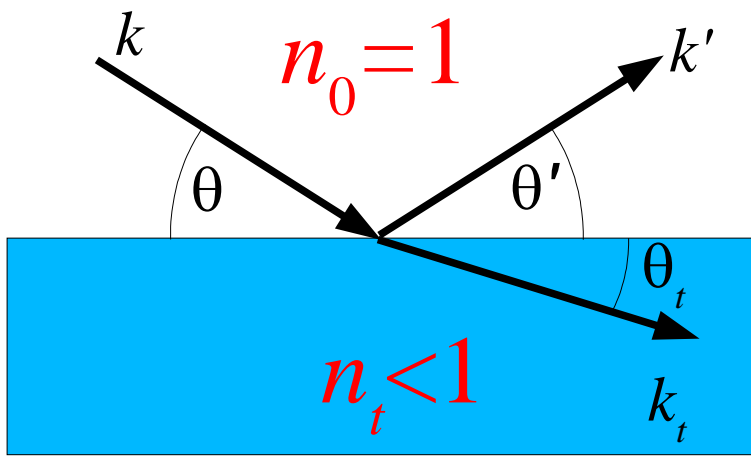
$$r_f = \frac{k_z - k_{t,z}}{k_z + k_{t,z}}$$

with

$$k_z = k \sin \theta$$

$$k_{t,z} = k_t \sin(\theta_t) = k \sqrt{n_t^2 - \cos^2 \theta}$$

$$k = 2\pi / \lambda$$



Evanescent Wave for $\theta \leq \alpha_c$

- real part of $k_{t,z}$ is zero
- imaginary part still exists with finity penetration depth (see below)

$$k_{t,z} = k \sqrt{n_t^2 - \cos^2(\theta)} = k \sqrt{(1 - \delta + i\beta)^2 - \cos^2(\theta)} \approx k \sqrt{1 - 2\delta + 2i\beta - (1 - \sin^2 \theta)}$$

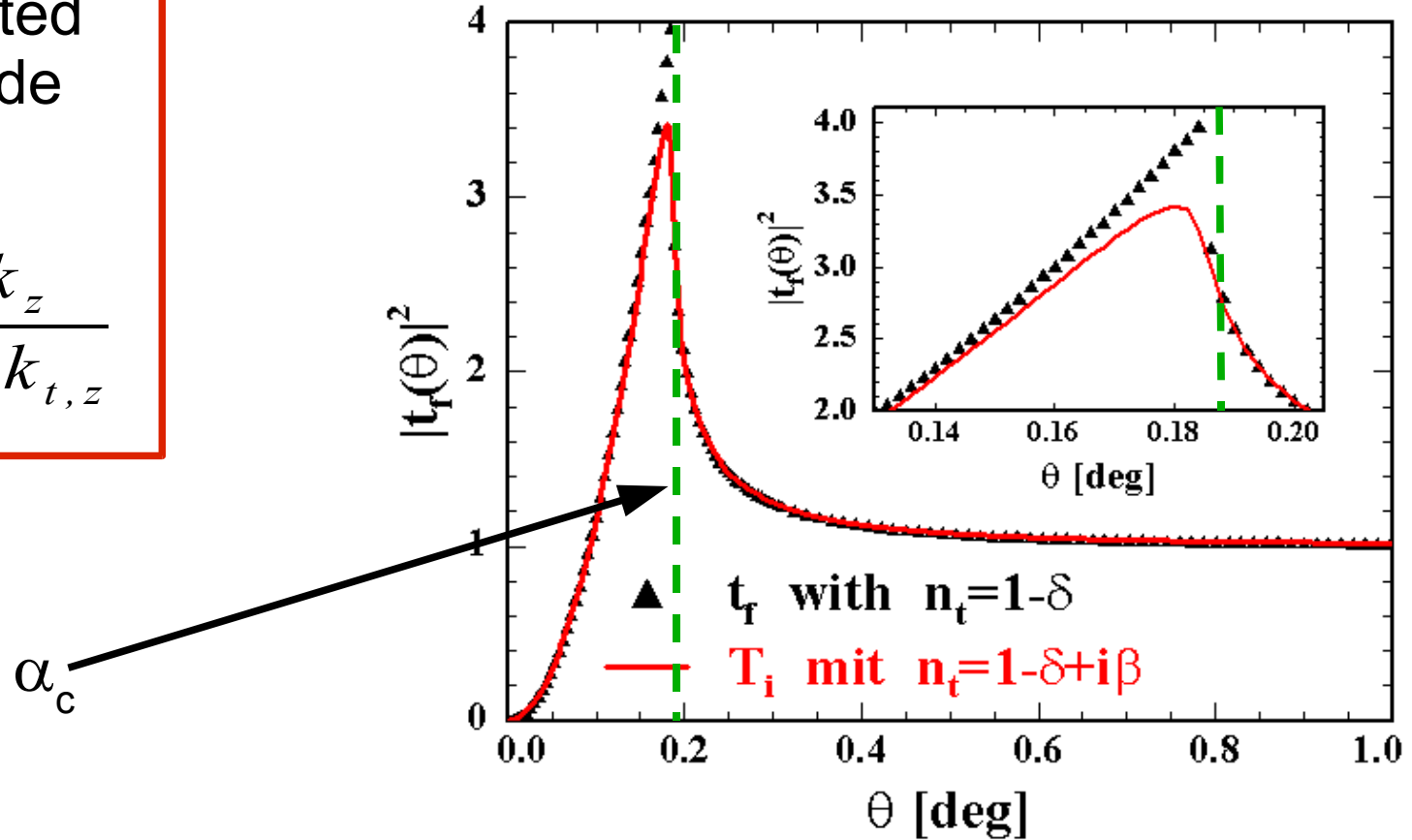
$$\approx k \sqrt{1 - 2\delta + 2i\beta - 1 + \theta^2} \approx k \sqrt{\theta^2 - 2\delta + 2i\beta} = k \sqrt{\theta^2 - \alpha_c^2 + 2i\beta} = k_{t,z}$$

for small θ and δ and β

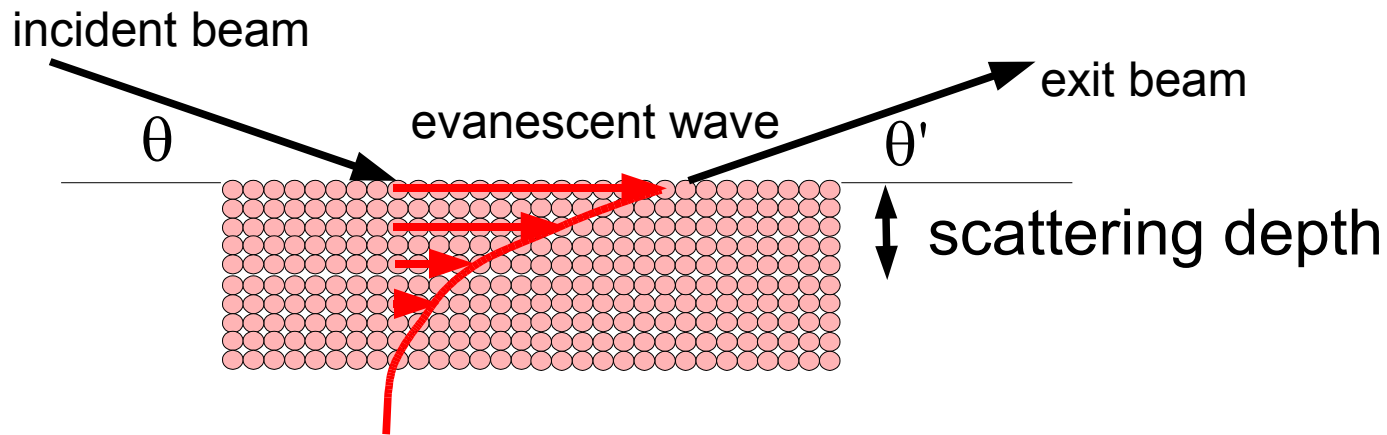
transmitted
amplitude

$$t_f = \frac{2k_z}{k_z + k_{t,z}}$$

typical transmission coefficient @ 8keV photons



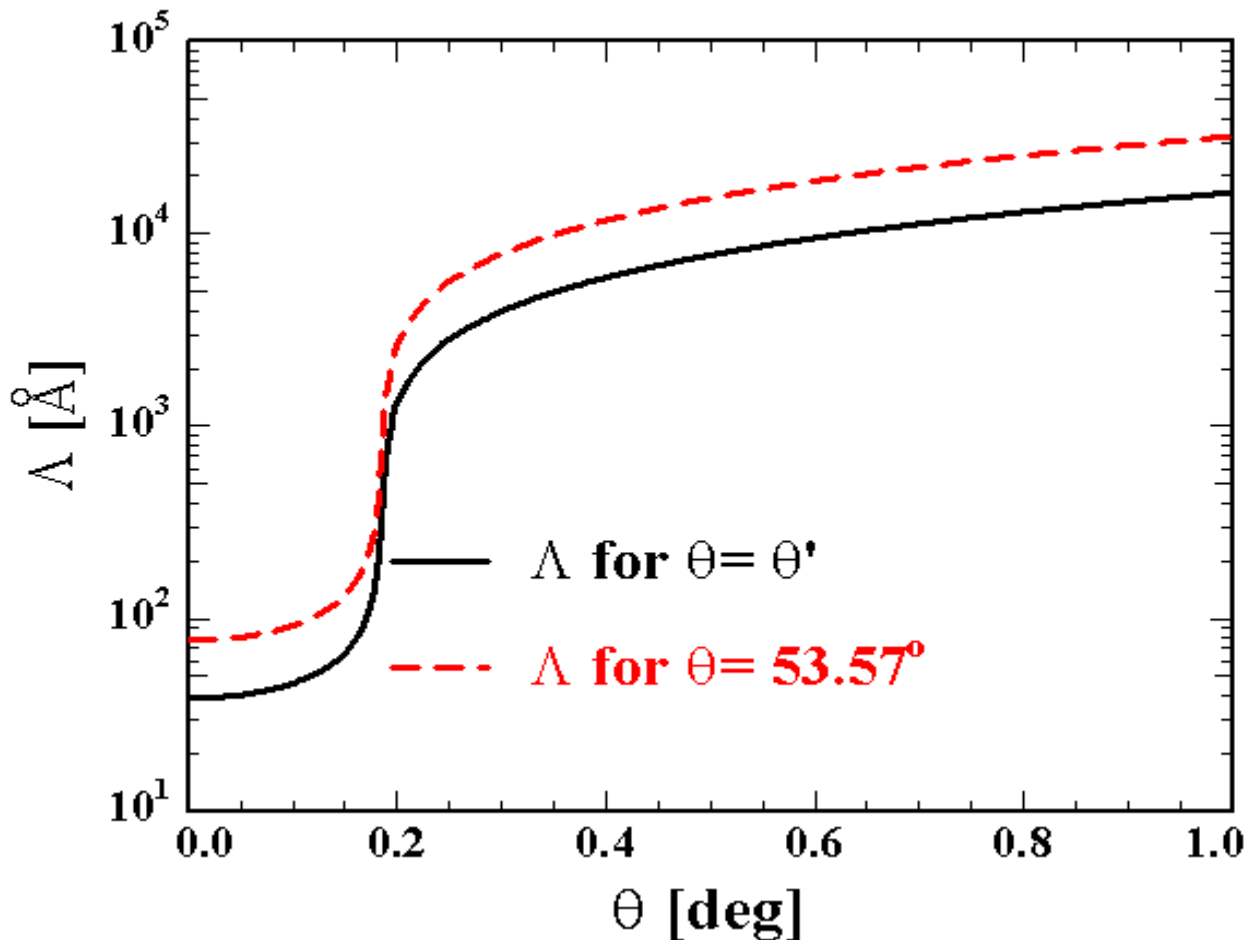
Amplification of the signal at the critical angle by a factor of 4



$$q_{zs} = k_{t,z}(\theta) + k_{t,z}(\theta')$$

$$\Lambda = \frac{1}{|\text{Im}\{q_{zs}\}|}$$

typical scattering depth (8keV photons)



Can be used to tune the sensitivity to the surface:

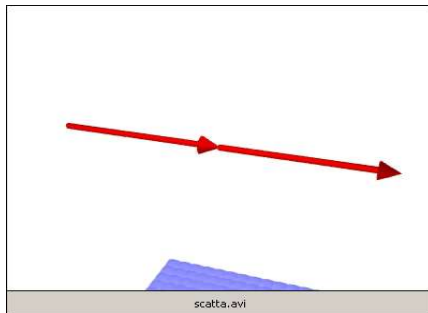
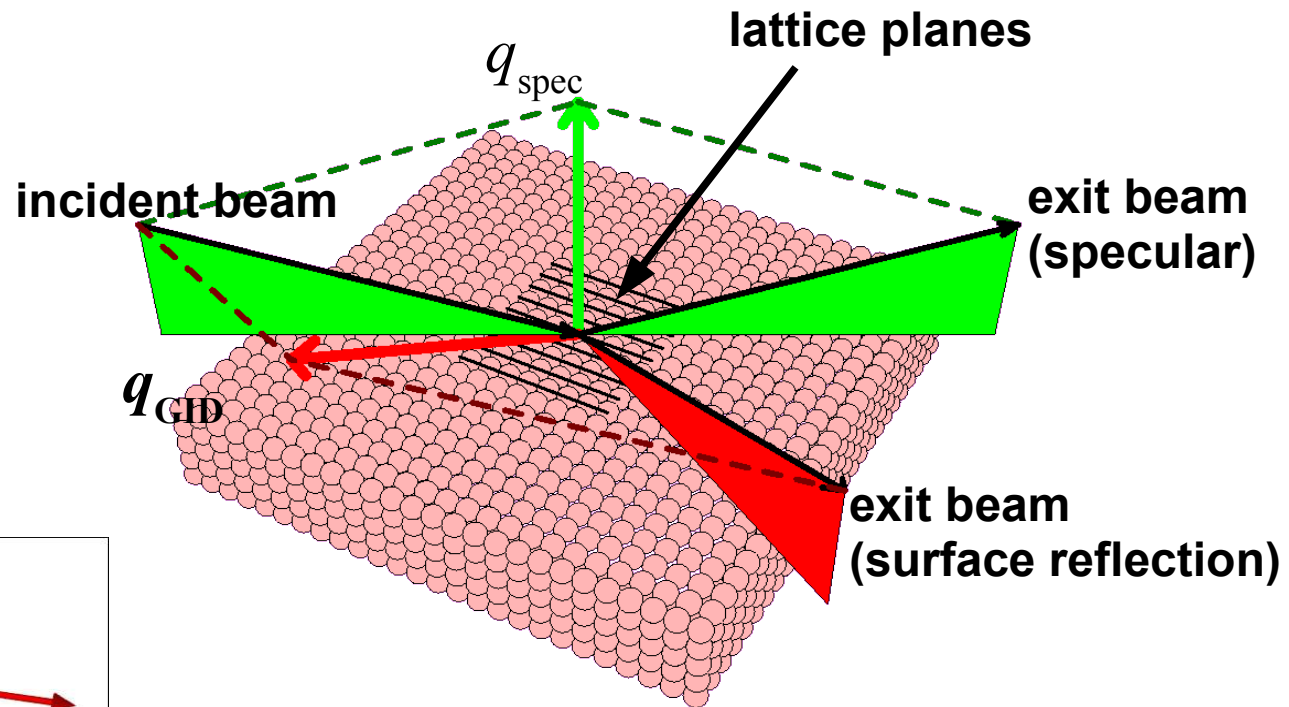
small angle =>
only sensity to surface

large angle =>
sensity to bulk

Grazing Incidence Diffraction

The experiment

Excite lattice planes perpendicular to the surface with the use of the evanescent wave



reflected intensity scales with transmission functions

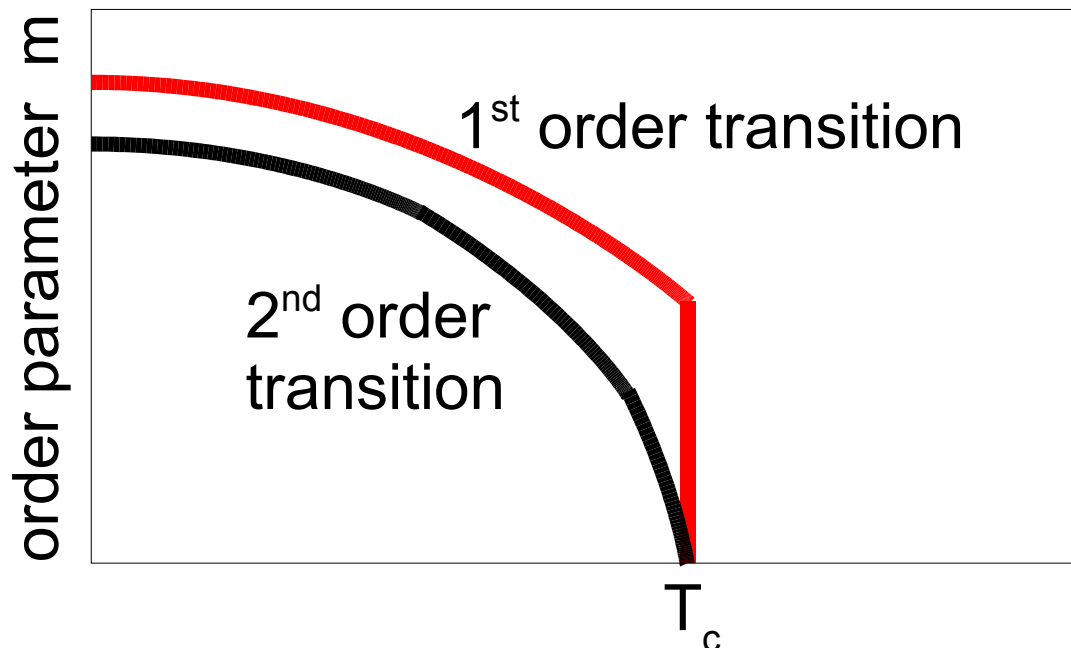
$$I(\mathbf{q}) \sim |t_f(\theta)|^2 |S(\mathbf{q})|^2 |t_f(\theta')|^2$$

$S(\mathbf{q})$: structure factor of the reflection

Example: Surface phase transition

Phase transition

- Matter changes internal order with temperature
- usually: below phase transition temperature $T_c \Rightarrow$ ordered
above phase transition temperature $T_c \Rightarrow$ disordered
- abrupt change of order :
1st order transition
- continuous loss of order at increasing temperature :
2nd order transition



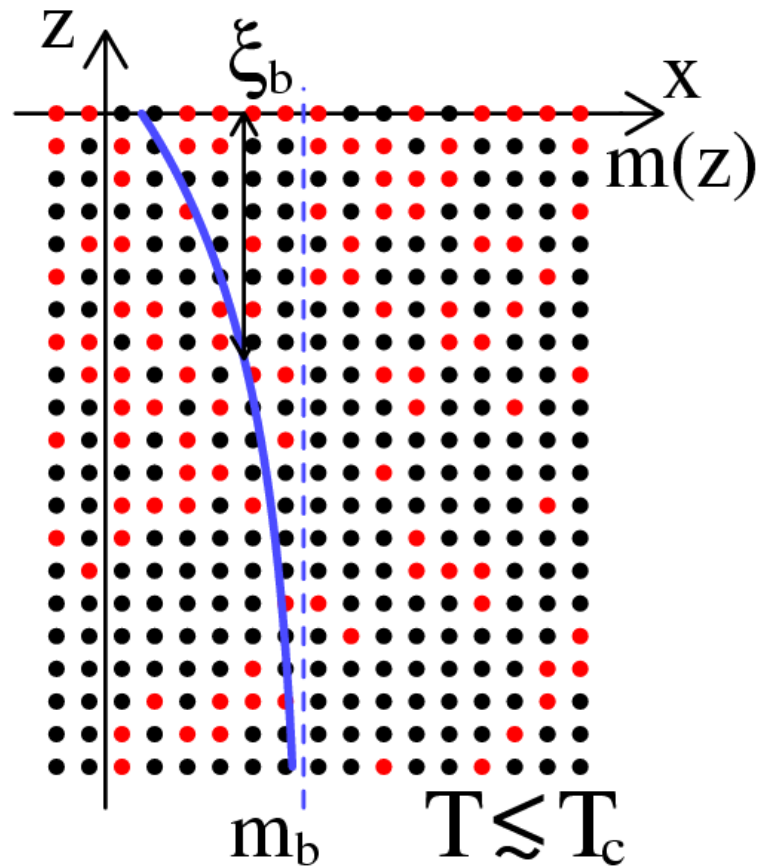
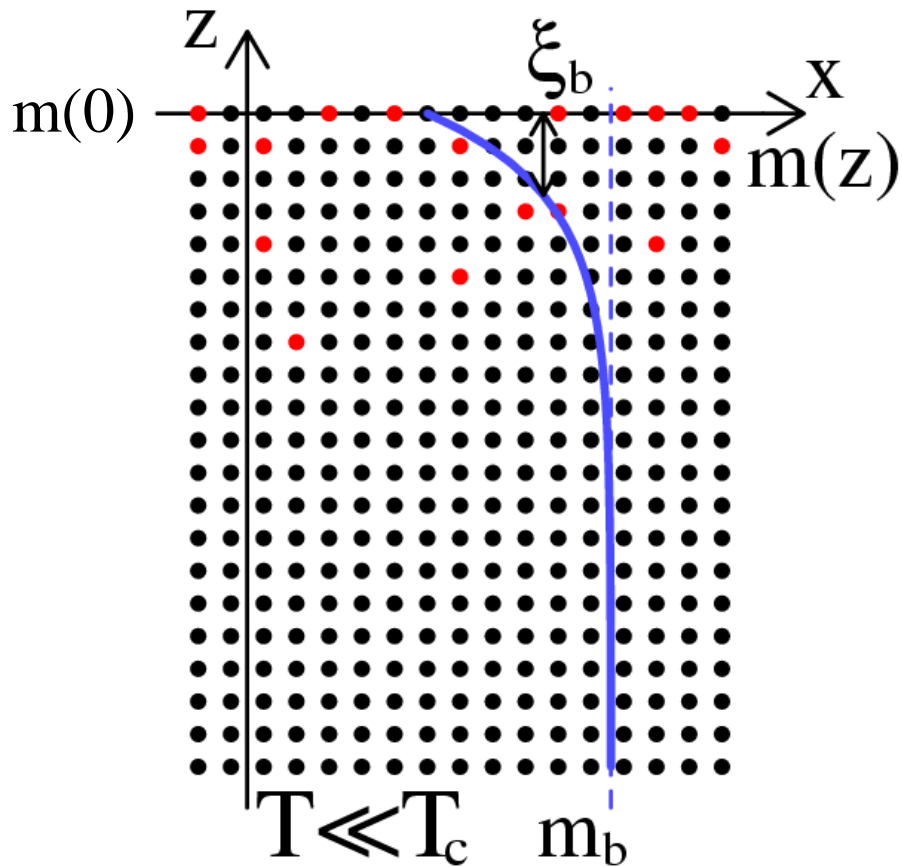
2nd order phase transitions:
power laws of the order
parameter with
universal critical exponents

$$m \sim \left(- \frac{T - T_c}{T_c} \right)^\beta$$

$\beta = 0.325$ for Ising model

Phase transition at the surface not identical to bulk (symmetry break at the surface)

Order parameter m depends on distance from surface : $m(z)$



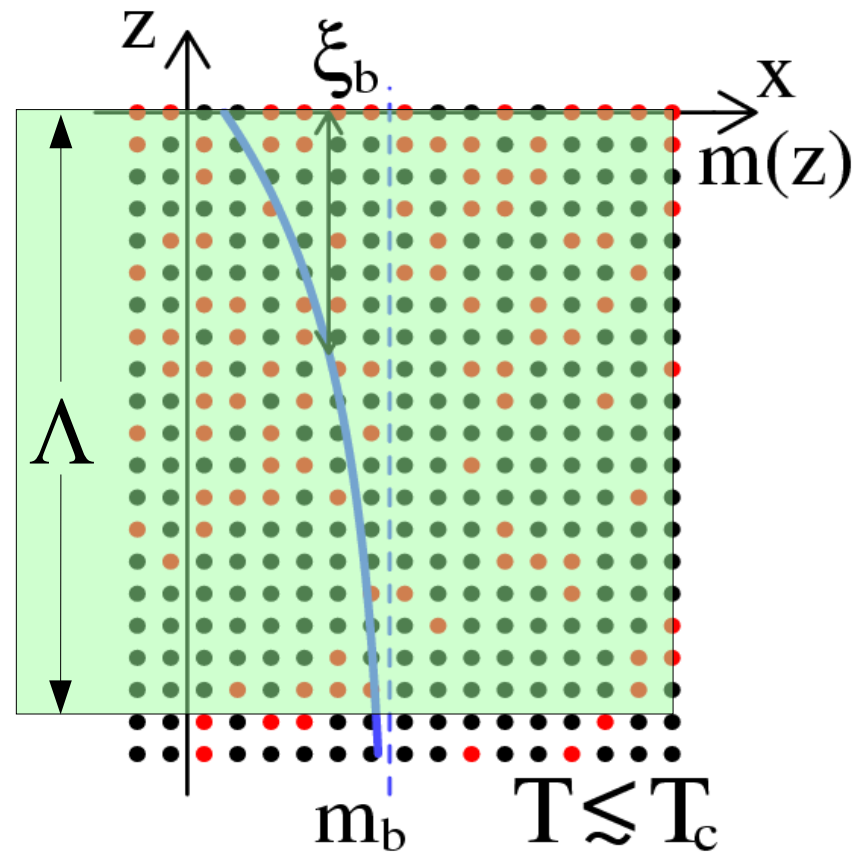
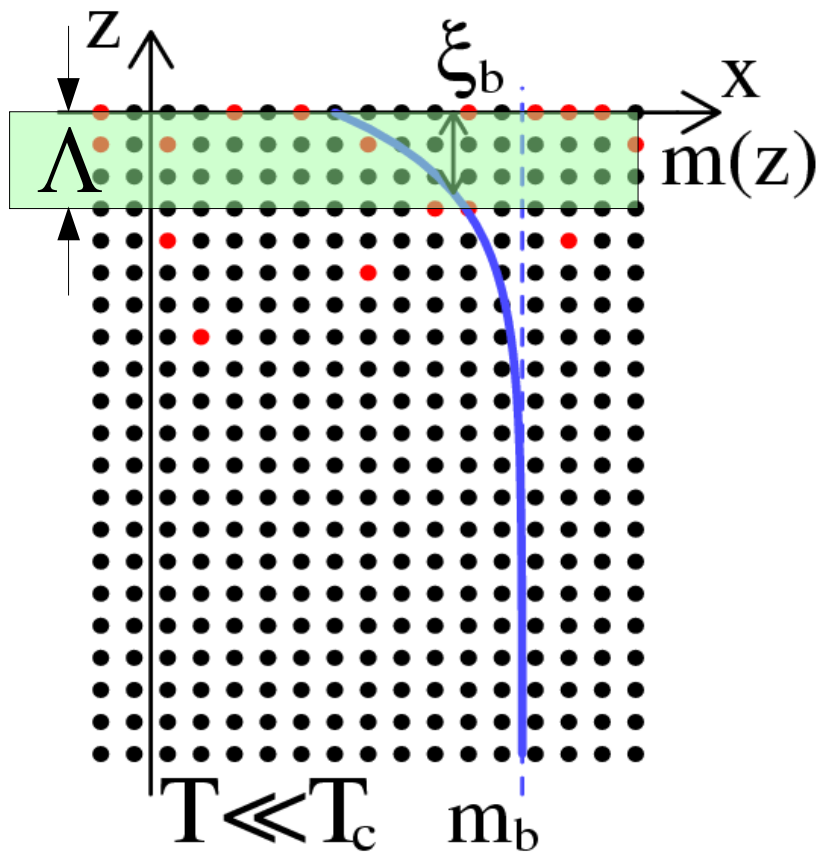
$$m(0) \sim \left(- \frac{T - T_c}{T_c} \right)^{\beta_{surf}}$$

$\beta_{surf} = 0.8$ for Ising model

Using GID (changing scattering depth by changing the incident angle) the experiment can be sensitive to $m(0)$ or m_{bulk}

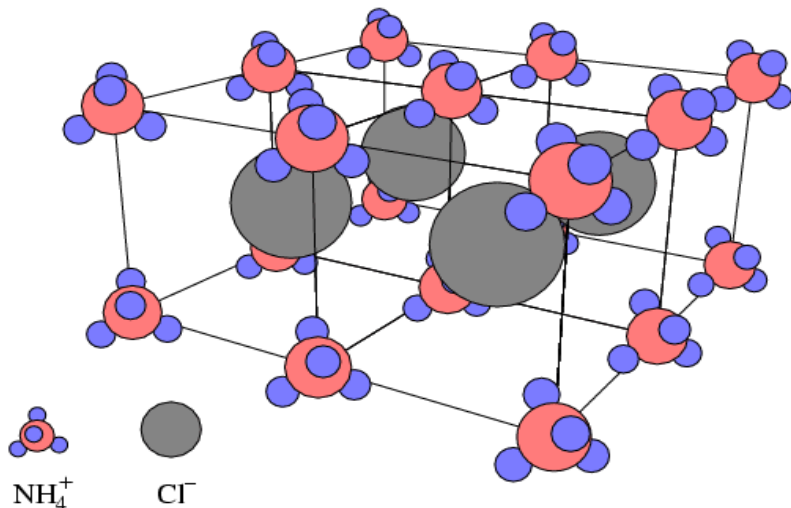
Small incident angle : small scattering depth $\Lambda \Rightarrow m(0)$

Large incident angle : large scattering depth $\Lambda \Rightarrow m_{\text{bulk}}$



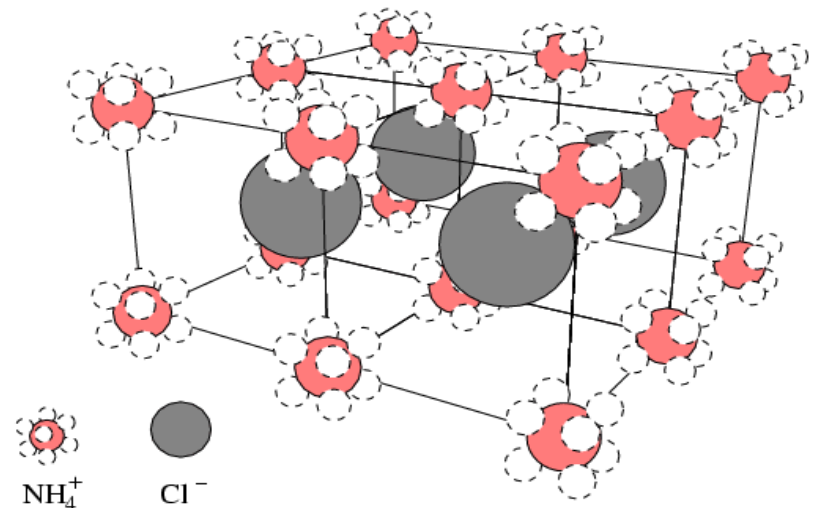
System Ammonium Chloride : deuterated NH_4Cl

$P4_3m$



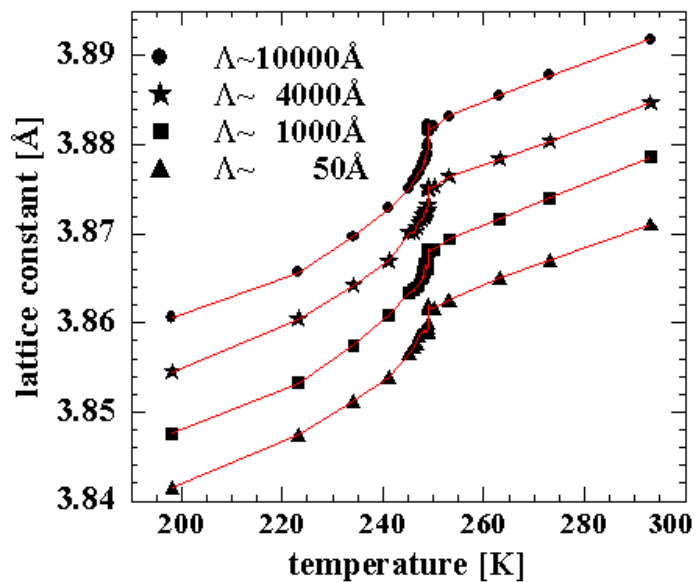
ordered low temperature phase

$Pm\bar{3}m$

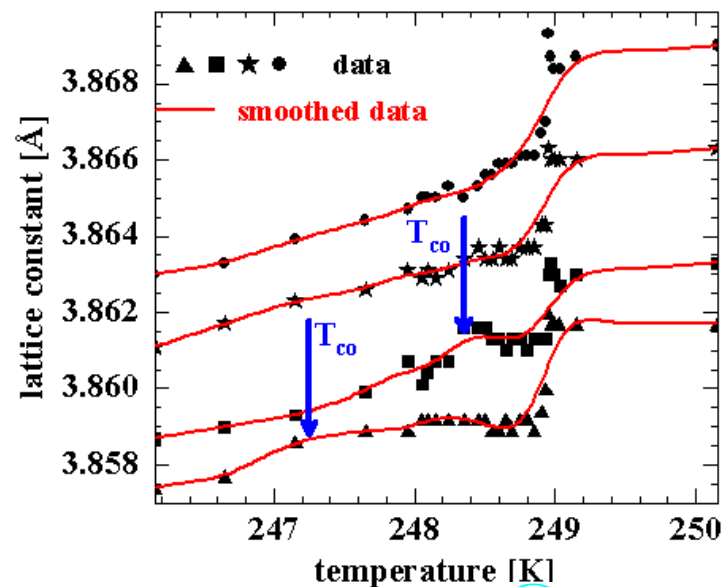


disordered high temperature phase

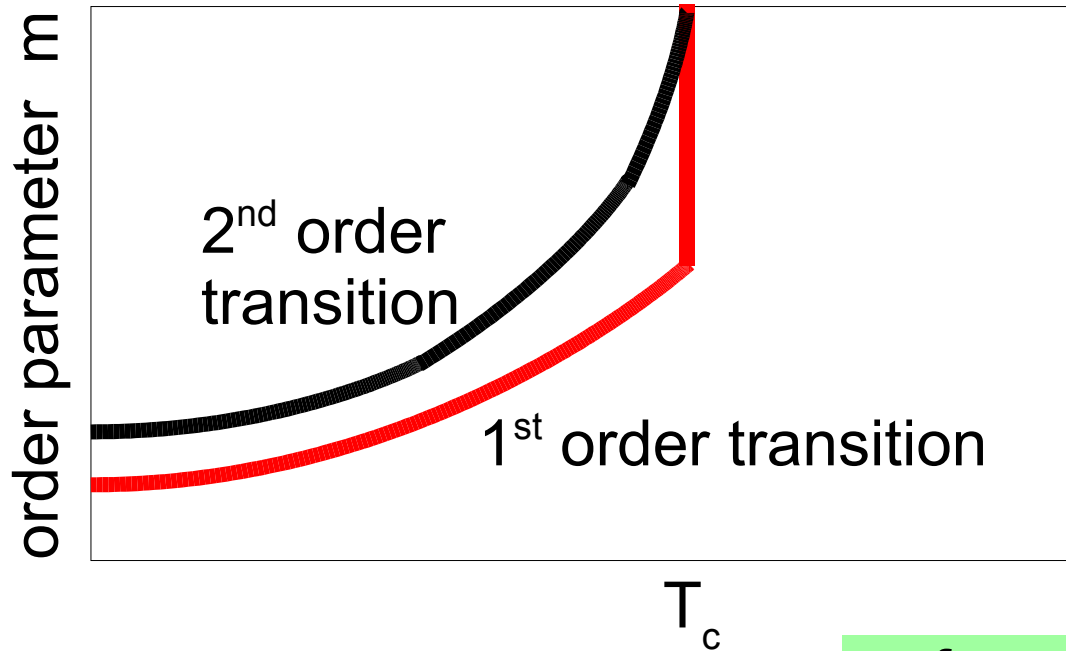
deuterated NH_4Cl 100-GID reflection



close look at T_c



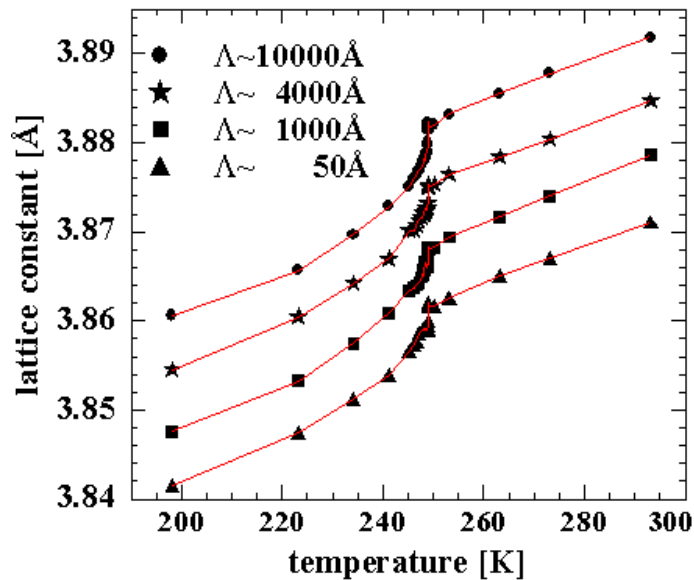
close to T_c :
change
of scattering
 Λ dependent



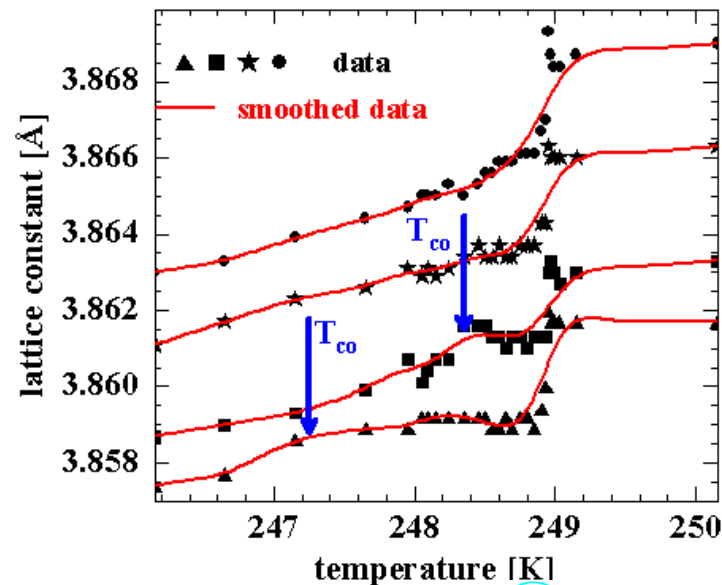
Looks like 2nd order

surface sensitive : 1st order surface phase transition ?

deuterated NH₄Cl 100-GID reflection



close look at T_c



close to T_c :
change
of scattering
Λ dependent

Summary

- **Grazing incidence diffraction** can be used to investigate crystalline surface regions
- The **surface-sensitivity** can be tuned via the **incident angle of the x-ray radiation**.
- The **scattered intensity** is amplified if the **incident angle is equal to the critical angle**.